

Notice of References Cited	Application/Control No. 09/983,041		Applicant(s)/Patent Under Reexamination SHIBUYA, ATSUSHI	
	Examiner Hai V. Nguyen		Art Unit 2142	Page 1 of 1

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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